SN54F258, SN74F258 QUADRUPLE 2-LINE TO 1-LINE DATA SELECTORS/MULTIPLEXERS WITH 3-STATE OUTPUTS

SDFS067A - D2932, MARCH 1987 - REVISED OCTOBER 1993

- 3-State Outputs Interface Directly With System Bus
- Provides Bus Interface From Multiple Sources in High-Performance Systems
- Package Options Include Plastic Small-Outline Packages, Ceramic Chip Carriers, and Standard Plastic and Ceramic 300-mil DIPs

description

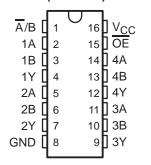
The 'F258 is designed to multiplex signals from 4-bit data sources to 4-output data lines in bus-organized systems. The 3-state outputs will not load the data lines when the output-enable (\overline{OE}) input is at a high logic level.

The SN54F258 is characterized for operation over the full military temperature range of -55° C to 125°C. The SN74F258 is characterized for operation from 0°C to 70°C.

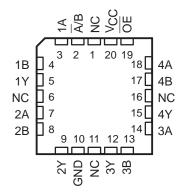
FUNCTION TABLE

	OUTPUT			
OE	A/B	Α	В	Y
Н	Х	Χ	Х	Z
L	L	L	X	Н
L	L	Н	X	L
L	Н	Χ	L	Н
L	Н	Χ	Н	L

SN54F258 . . . J PACKAGE SN74F258 . . . D OR N PACKAGE (TOP VIEW)

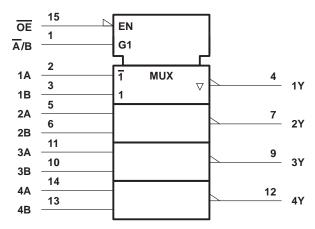


SN54F258...FK PACKAGE (TOP VIEW)



NC - No internal connection

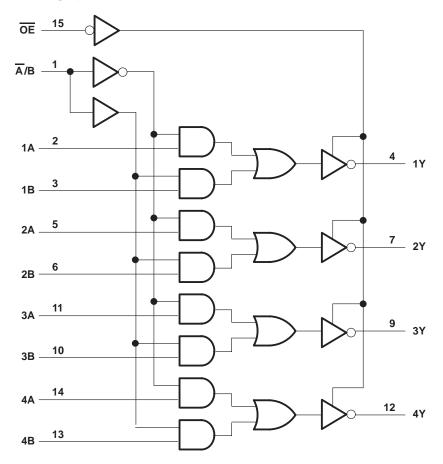
logic symbol†



[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12. Pin numbers shown are for the D, J, and N packages.



logic diagram (positive logic)



Pin numbers shown are for the D, J, and N packages.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage range, V _{CC}		
Input current range		
Voltage range applied to any output in		
Voltage range applied to any output in	the high state	0.5 V to V _{CC}
Current into any output in the low state	: SN54F258	40 mÅ
		48 mA
Operating free-air temperature range:		
		0°C to 70°C
Storage temperature range		–65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The input voltage ratings may be exceeded provided the input current ratings are observed.



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recommended operating conditions

		SN54F258		SN74F258			UNIT	
		MIN	NOM	MAX	MIN	NOM	MAX	UNIT
Vcc	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
VIH	High-level input voltage	2			2			V
V _{IL}	Low-level input voltage			0.8			0.8	V
ΙΙΚ	Input clamp current			-18			-18	mA
IOH	H High-level output current			-3			-3	mA
lOL	Low-level output current			20			24	mA
TA	Operating free-air temperature	-55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS		SN54F258			SN74F258			UNIT
			MIN	TYP	MAX	MIN	TYP	MAX	UNII
VIK	$V_{CC} = 4.5 \text{ V},$	$I_{I} = -18 \text{ mA}$			-1.2			-1.2	V
	V 45V	$I_{OH} = -1 \text{ mA}$	2.5	3.4		2.5	3.4		
Voн	V _{CC} = 4.5 V	$I_{OH} = -3 \text{ mA}$	2.4	3.3		2.4	3.3		V
	$V_{CC} = 4.75 \text{ V},$	$I_{OH} = -1 \text{ mA to } -3 \text{ mA}$				2.7			
VoL	V00 - 45 V	$I_{OL} = 20 \text{ mA}$		0.3	0.5				.5 V
VOL	V _{CC} = 4.5 V	$I_{OL} = 24 \text{ mA}$					0.35	0.5	
lozh	$V_{CC} = 5.5 \text{ V},$	$V_0 = 2.7 \text{ V}$			50			50	μΑ
lozL	$V_{CC} = 5.5 \text{ V},$	$V_0 = 0.5 V$			-50			-50	μΑ
ΙĮ	$V_{CC} = 5.5 \text{ V},$	V _I = 7 V			0.1			0.1	mA
lіН	$V_{CC} = 5.5 \text{ V},$	V _I = 2.7 V			20			20	μΑ
I _{IL}	$V_{CC} = 5.5 \text{ V},$	V _I = 0.5 V			- 0.6			- 0.6	mA
los [‡]	$V_{CC} = 5.5 \text{ V},$	VO = 0	-60		-150	-60		-150	mA
Іссн	V _{CC} = 5.5 V, See Note 2	Condition A		6.2	9.5		6.2	9.5	
ICCL		Condition B		15.1	23		15.1	23	mA
Iccz		Condition C		11.3	17		11.3	17	

[†] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.

- A. All B inputs at 4.5 V, other inputs grounded
- B. \overline{A}/B and all B inputs at 4.5 V, other inputs grounded
- C. OE and all B inputs at 4.5 V, other inputs grounded

[‡] Not more than one output should be shorted at a time, and the duration of the short circuit should not exceed one second.

NOTE 2: I_{CC} is measured with the outputs open under the following conditions:

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switching characteristics (see Note 3)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V_{CC} = 5 V, C_{L} = 50 pF, R1 = 500 Ω, R2 = 500 Ω, T_{A} = 25°C		C R R	L = 50 p 1 = 500 g 2 = 500 g A = MIN F258	2,	F258	UNIT		
			MIN	TYP	MAX	MIN	MAX	MIN	MAX		
t _{PLH}	Data (A or B)	Any Y	1	3.6	5.3	1	7.5	1	6	ns	
^t PHL		Ally I	1	3.1	4.7	1	6	1	5.5	115	
^t PLH	A/B	Any Y	3.2	6.1	8.5	3.2	12	3.2	9.5	ns	
^t PHL		Ally I	3.2	6.9	9.5	3.2	11.5	3.2	11	110	
^t PZH	G	C Apy V	Any Y	2.2	5.5	7.5	2.2	11	2.2	8.5	ns
t _{PZL}		Ally I	2.2	5.1	7.5	2.2	9.5	2.2	8.5	115	
t _{PHZ}	G	Any V	1.2	3.9	6	1	7	1.2	7		
tPLZ		Any Y	1.2	4.1	6	1.2	9	1.2	7	ns	

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions. NOTE 3: Load circuits and waveforms are shown in Section 1.



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